



Atty. Dkt. No.	M#	Client Ref.
	0305303	T4YK-02S1556-1

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: YONEZAWA	
Appln. No.: 10/629,894	
Filing Date: July 30, 2003	
Examiner: Unknown	Group Art Unit: 2055

Date: November 9, 2004 Page 1 of 1

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
	CR					
	DR					
	ER					
	FR					
	GR					
	HR					
	IR					
	JR					
	KR					
	LR					
	MR					
	NR					

FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
TD	OR	2001-126270	05/2001	JAPAN	Aizawa et al.	x			
↓	PR	2000-331353	11/2000	JAPAN	Ueki et al.	x			
	QR	10-134364	05/1998	JAPAN	Aoki	x			
	RR	2000-048378	02/2000	JAPAN	Seki	x			
TD	SR	6-290469	10/1994	JAPAN	Kusakari et al.	x			
	TR								
	UR								
	VR								
	WR								
	XR								

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

YR	Japanese Office Action for Japanese Patent Application No. 2002-224833, dated September 14, 2004.
ZR	
AAR	
BBR	
CCR	

Examiner /Tan Dinh/ Date Considered: 09/11/2006

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

FORM PTO-1449 (modified)
To: U.S. Department of Commerce
(PW FORM PAT-1449)
Patent and Trademark Office



Atty. Dkt. No.	M#	Client Ref.
	008312-0305303	T4YK-02S1556-1

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: Yonezawa	
Appln. No.: 10/629,894	
Filing Date: July 30, 2003	
Examiner: Unassigned	Group Art Unit: 2655

Date: July 25, 2005

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U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
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	JR					
	KR					
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	NR					

FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
TD	OR	JP 06-176376	06/1994	Japan	YANAGAWA	x			
TD	PR	JP 2001-034961	02/2001	Japan	IIDA et al.	x			
	QR								
	RR								
	SR								
	TR								
	UR								
	VR								
	WR								
	XR								

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)									
YR	Chinese Office Action dated April 29, 2005 for Appln. No. 00152424.0								
ZR									
AAR									
BBR									

Examiner /Tan Dinh/	Date Considered: 09/11/2006
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Atty.
Dkt. No.

M#

Client Ref.

0305303

T4YK-02S1556-1

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: YONEZAWA, Minoru

Appln. No.: ~~UNASSIGNED~~ 10/629,894

Filing Date: July 30, 2003

Date: July 30, 2003

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of

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Examiner: ~~UNKNOWN~~

Group Art Unit: ~~UNKNOWN~~

U.S. PATENT DOCUMENTS

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Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
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	ER					
	FR					
	GR					
	HR					
	IR					
	JR					
	KR					
	LR					
	MR					
	NR					

FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
TD	OR	2000-251271	09/2000	Japan			X		X
TD	PR	2000-207750	07/2000	Japan			X		X
	QR								
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	SR								
	TR								
	UR								
	VR								
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OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

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